

Application/Control No.	Applicant(s)/Patent under Reexamination COLLINS, JAMES D.			
10/605,690				
Examiner	Art Unit			

		18	SSUE	CLASSIFIC	ATION		
OR	IGINAL			CROSS REFERENCE(S)			
CLASS	SUBCLASS	CLASS		SUBC	LASS (ONE SUBCLASS	PER BLOCK)	
235	379	235	47!	5 479			
INTERNATIONA	L CLASSIFICATION						
G 0 6 F	17/60						
0 0 1 '							
	1						
	1						
	1						
	•/						
	-		\mathcal{O}_{i}				
	H Lee 8/23/200	*********		· (uc		Total Claims Allowed: 34	
(Assista	int Examiner) (Dat	e)	D0	DIANE I. LEE	_ ,	O.G.	O.G.
//1/. //	n/h a	سدلها	rh	IMARY EXAMINE	9/5/05	Print Claim(s)	Print Fig.
(regen Institu	ments Examiner)	(Date)		(Primary Examiner)	(Date)	1	1
						I	,
⊠ Claims re	enumbered in the	same orde	er as pro	esented by applica	nt CPA	☐ T.D.	☐ R.1.47
_ 펼	E	- E] a	Ec	ے ا عا	<u> </u> <u> </u>	ے ا اور
Final	Final	Final	Original	Final	Final	Final	Final Original
" ō	" ō		Ō	- ō	- 0		
1 1	3] 31		61	91	121	151	181
<u>구</u> 2	32 32		62	92	122	152	182
3 ⊈ 4	3 5 33 3 V 34		63 64	. 93 94	123 124	153 154	183
5 5	35		65	95	125	155	185
6	36		66	96	126	156	186
h 7	37		67	97	127	157	187
8 q	38		68	98	128	158	188
9 9	39		69	99	129	159	189
16 10 11 11	40		70 71	100	130	160	190 191
12 12	42		72	101	132	162	192
13 13	43		73	103	133	163	193
/¢ 14	44		74	104	134	164	194
15 15	45		75	105	135	165	195
16 16	46		76	106	136	166	196
'/ 7 17 1₽ 18	47		77 78	107	137	167	197 198
19 10	49		79	109	139	169	199
20 20	50		80	110	140	170	200
거 21	51		81	111	141	171	201
그느 22	52		82	112	142	172	202
23 23	53		83	113	143	173	203
24 24 25 25	54 55		84 85	114	144	174 175	204 205
26 26	56		86	116	145	176	205
27 27	57		87	117	147	177	207
28 28	58		88	118	148	178	208
29 29	59		89	119	149	179	209
J/ 30	60	:::::::	വ	120	150	1 180	210

Seung H. Lee